

Title (en)  
NON-VOLATILE MEMORY REPAIR CIRCUIT

Title (de)  
REPARATURSCHALTUNG FÜR NICHTFLÜCHTIGEN SPEICHER

Title (fr)  
CIRCUIT DE RÉPARATION DE MÉMOIRE NON VOLATILE

Publication  
**EP 3392885 A1 20181024 (EN)**

Application  
**EP 18162862 A 20180320**

Priority  
CN 201710255450 A 20170419

Abstract (en)  
An integrated circuit includes on-chip flash memory, a EEPROM, cache memory, and a repair controller. When a defective address is detected in the flash memory, data slotted to be stored at the defective address is stored in the EEPROM by the repair controller. The cache memory includes a content addressable memory (CAM) that checks read addresses with the defective memory address and if there is a match, the data stored in the EEPROM is moved to the cache so that it can be output in place of data stored at the defective location of the flash memory. The memory repair system does not require any fuses nor is the flash required to include redundant rows or columns. Further, defective addresses can be detected and repaired on-the-fly.

IPC 8 full level  
**G11C 29/00** (2006.01); **G11C 29/44** (2006.01); **G11C 29/04** (2006.01); **G11C 29/12** (2006.01)

CPC (source: CN EP US)  
**G06F 11/0793** (2013.01 - US); **G06F 11/1064** (2013.01 - US); **G06F 11/1666** (2013.01 - US); **G06F 11/18** (2013.01 - US);  
**G06F 11/181** (2013.01 - US); **G06F 11/2094** (2013.01 - US); **G11C 29/44** (2013.01 - CN US); **G11C 29/4401** (2013.01 - EP US);  
**G11C 29/76** (2013.01 - EP US); **G11C 29/789** (2013.01 - EP US); **G11C 29/808** (2013.01 - EP US); **G11C 29/846** (2013.01 - EP US);  
**G06F 2201/805** (2013.01 - US); **G06F 2201/82** (2013.01 - US); **G11C 2029/0403** (2013.01 - EP US); **G11C 2029/1208** (2013.01 - EP US);  
**G11C 2029/4402** (2013.01 - EP US)

Citation (search report)  
• [X] US 2017083418 A1 20170323 - LI YAOQIAO [CN], et al  
• [I] US 2009161431 A1 20090625 - HSIAO YU YING [TW], et al  
• [I] US 2006140027 A1 20060629 - TOMINAGA KENICHIROU [JP]  
• [A] US 2014082453 A1 20140320 - SIKDAR DIPAK K [US], et al  
• [A] US 2003035322 A1 20030220 - WONG SAU CHING [US]

Cited by  
EP4362022A1; US11989417B1

Designated contracting state (EPC)  
AL AT BE BG CH CY CZ DE DK EE ES FI FR GB GR HR HU IE IS IT LI LT LU LV MC MK MT NL NO PL PT RO RS SE SI SK SM TR

Designated extension state (EPC)  
BA ME

DOCDB simple family (publication)  
**EP 3392885 A1 20181024**; **EP 3392885 B1 20201111**; CN 108735268 A 20181102; CN 108735268 B 20240130; US 10229025 B2 20190312;  
US 2018308562 A1 20181025

DOCDB simple family (application)  
**EP 18162862 A 20180320**; CN 201710255450 A 20170419; US 201715593326 A 20170512